



























Exams for group M17-406

Thu, 29 Nov	08:30 — 10:05	TEST	Law and Economics of Scientific Projects and Units  Nurahov N.N.  V-404
Tue, 25 Dec	12:45 — 14:20	TEST	Principles of Nuclear Technologies  Apse V.A.  B-100
Tue, 25 Dec	14:30 — 16:05	TEST	Practical Training (Research Work)  Barbashov V.M.  dep.3
Thu, 27 Dec	10:15 — 11:50	TEST	Computer Technology  Krasavin A.V.  V-116
Thu, 27 Dec	12:45 — 14:20	ATT	Elements of Fault-tolerant Devices  Skorobogatov P.K.  V-306
Thu, 27 Dec	15:20 — 17:00	ATT	Computer Technology: Electronic Design Automation (Eda)  Kalashnikov O.A., Nekrasov P.V.  V-315
Fri, 28 Dec	08:30 — 10:05	ATT	Electronic Systems Design  Alyushin M.V.  V-306
Fri, 28 Dec	12:00 — 14:20	TEST	Legal and International Aspects of Nonproliferation and Nuclear Materials Safety.  Bogdanovich R.B., Baratova A.A., Kulikov E.G.  B-100
Fri, 28 Dec	14:30 — 16:05	ATT	Principles of Nuclear Electronics  Atkin E.V., Garmash A.A.  V-315
Thu, 10 Jan	09:00 — 13:00	EXAM	Computer Technology: Electronic Design Automation (Eda)  Kalashnikov O.A.  V-315
Mon, 14 Jan	09:00 — 13:00	EXAM	Elements of Fault-tolerant Devices  Skorobogatov P.K.  V-306
Fri, 18 Jan	09:00 — 13:00	EXAM	Electronic Systems Design  Alyushin M.V.  V-306
Tue, 22 Jan	09:00 — 13:00	EXAM	Principles of Nuclear Electronics  Atkin E.V.  D-305